

Certificate of non-use of The Controlled Substances

Company name Littelfuse, LP (Subsidiary of Littelfuse, Inc.)

Product Covered Thyristor TO-218 J & K Packages (Isolated)

Thyristor TO-218 M & W Packages (Non-isolated)

SIDACtor® TO-218 Package

Issue Date August 13, 2010

It is hereby certified by Littelfuse, LP, that there is neither RoHS (EU Directive 2002/95/EC)-restricted substance nor such use, for materials to be used for unit parts, for packing/packaging materials, and for additives and the like in the manufacturing processes.

It is also certified by Littelfuse, Inc., that the products listed in this report do not contain Halogens and their compounds judged per widely accepted industrial guidelines.

In addition, it is hereby reported to you that the parts and sub-materials, the materials to be used for unit parts, the packing/packaging materials, and the additives and the like in the manufacturing processes, are all composed of the following components.

Issued by			

< K. Yoshimoto, Senior Product Engineer, Littelfuse, L.P.>

(1) Parts, sub-materials and unit parts

This document covers Thyristor and SIDACtor TO-218 series products supplied by Littelfuse. Actual values in this report are taken from S4065K (representing TO-218 Isolated package) and S8070W (representing TO-218 non-isolated package including SIDACtor) and the result is generally applicable to all TO-218 products. Please see page 2 and 3 for the complete list of part number covered by this report.

< Homogeneous Materials used >

Please see figure and table 1 on page 4 and table 2 on page 5 and 6 of this document.

(2) The analytical data on all measurable substances

Please see annex 1 through 7, attached to this document. Please also see annex 4 (part B) for Halogen testing of entire component using P2300MEL as representative sample.

Remarks:

1. Pb (lead) contained in die bonding solder (item 8 on page 4) and passivation glass (item 7) to be categorized as exempt in RoHS Annex 5 and 7.

Please refer to Annex 8 of this report for the extract of the applicable exemptions of RoHS (EU Directive 2002/95/EC)

August 13, 2010 Littelfuse, L.P. Page 1



Littelfuse Part Number covered by this report (1/2) TO-218 isolated package

	ber	SPECIAL DEVICE P/N		
Q2025J6	Q7025J6	S0335J	S8065J	
Q2025K6	Q7025K6	S0335K	S8065K	Any Special P/N that has base
Q2040J7	Q7040J7	S0535J	SK035K	standard P/N listed in this table
Q2040J9	Q7040J9	S0535K	SK065K	
Q2040K7	Q7040K7	S0550J		
Q2040K9	Q7040K9	S0565J		
Q3025J6	Q7025J6	S0565K		
Q3025K6	Q7025K6	S1035J		
Q3040J7	Q7040J7	S1035K		
Q3040J9	Q7040J9	S1050J		
Q3040K7	Q8025J6	S1065J		
Q3040K9	Q8025K6	S1065K		OPTIONAL
Q4025J6	Q8040J7	S2035J		SUFFIX
Q4025K6	Q8040J9	S2035K		Any Part Number
Q4040J7	Q8040K7	S2050J		listed here may be followed by suffix
Q4040J9	Q8040K9	S2065J		for packing
Q4040K7	QK025K6	S2065K		options, such as "TP" and/or lead
Q4040K9	QK040K7	S4035J		form options such as "LB", "81", "82"
Q5025J6		S4035K		etc.
Q5025K6		S4050J		
Q5040J7		S4065J		
Q5040J9		S4065K		
Q5040K7		S6035J		
Q5040K9		S6035K		
Q6025J6		S6050J		
Q6025K6		S6065J		
Q6040J7		S6065K		
Q6040J9		S8035J		
Q6040K7		S8035K		
Q6040K9		S8050J		



Littelfuse Part Number covered by this report (2/2) TO-218 non-isolated package

	Standard (Catalog) Part Number			SPECIAL DEVICE P/N
P1500MEL	S0555M			
P1900MEL	S0555W			Any Special P/N that has base
P2300MEL	S0570W			standard P/N listed in this table
	S1055W			noted in this table
	S1070W			P589
Q2040W7	S2055M			P595P2300ME
Q2040W9	S2055W			S838
Q3040W7	S2070W			
Q3040W9	S4055M			
Q4040W7	S4055W			
Q4040W9	S4070W			
Q5040W7	S5070W			OPTIONAL
Q5040W9	S6055M			SUFFIX
Q6040W7	S6055W			Any Part Number
Q6040W9	S6070W			listed here may be followed by suffix
Q7040W7	S8055M			for packing
Q7040W9	S8055W			options, such as "TP" and/or lead
Q8040W7	S8070W			form options such as "LB", "81", "82"
Q8040W9	SK055M			etc.
	S0555M			



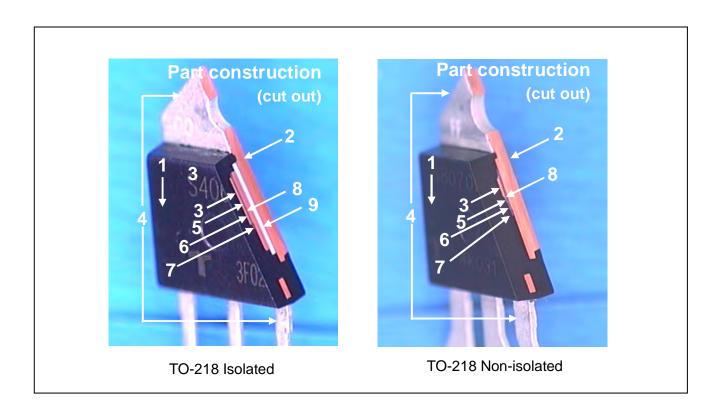


Table 1: Homogeneous Material Used

#	Description	Name of Material	Туре	Analysis data
1	Molding compound	epoxy resin	plastic	annex 1
2	Lead frame	copper alloy	metal	annex 2
3	Preform	copper alloy	metal	annex 2 Clip uses same copper material as lead frame
4	Matte-Tin plating	Tin	metal	annex 3
5	Silicon die	silicon	metal	annex 4, tested as Nickel-plated wafer.
6	Nickel electrode	nickel	metal	annex 4, tested as Nicker-plated water.
7	Passivation glass	glass	glass	annex 5. Pb in this glass is exempted by RoHS Annex 7.
8	Die bonding solder	solder	metal	annex 6. Pb in this solder is exempted by RoHS Annex 5.
9	Substrate	alumina	ceramic	annex 7, applicable to TO-218 Isolated packages only



Table 2: RoHS-regulated substance in raw materials

Components	Analysis Result						
	Cd Cadmium	Cr Chromium	Hg Mercury	Pb Lead	PBB	PBDE	Halogens (Total)
As Component Total (Values of S4065K *1, as representative of Thyristor, TO-218 J & K Package)	< 2ppm	< 2ppm	< 2ppm	<10 ppm* ² (1.0% ^{*3})	< 5 ppm	< 5 ppm	<50ppm
Epoxy Resin compound See Annex 1 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	<5 ppm	100ppm
Lead frame / Clip (Copper Alloy, KFC) See Annex 2 for the detail.	< 2ppm	< 2ppm	< 2ppm	11 ppm *4	< 5ppm	<5 ppm	
Outside lead finish (Matte-Tin plated, Sn 100%) See Annex 3 for the detail.	< 2ppm	< 2ppm	< 2ppm	24 ppm *4	< 5ppm	<5 ppm	
Silicon Die (Silicon wafer + Ni electrode) See Annex 4 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	<5 ppm	< 50ppm
Passivation Glass See Annex 5 for the detail.	< 2ppm	< 2ppm	< 2ppm	41% ^{*5}	< 5ppm	<5 ppm	< 50ppm
Die Bonding Solder (Pb/Sn/Ag=88/10/2) See Annex 6 for the detail.	< 2ppm	< 2ppm	< 2ppm	88 wt% *6	< 5ppm	<5 ppm	240ppm
Ceramic Substrate (Al_2O_3) See Annex 7 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	< 5ppm	<5 ppm	

- *1 Other products may contain equal or less amount of Pb as S4065K value shown here, but not more than the value shown here.
- *2 Less than 10ppm Pb content overall, <u>excluding</u> Pb from the die bonding solder and the passivation glass on the silicon die.
- *3 1.0wt% or 40mg of Pb (lead) content overall, including the RoHS-exempted use of Pb
- *4 Pb (lead) contained in lead frame and outside finish <u>not</u> exempted from restriction by RoHS, but considered as process contamination. Littelfuse does not add Pb (lead) intentionally.
- *5 Pb (lead) contained in passivation glass is exempted from restriction by RoHS Annex 5.
- *6 Pb (lead) contained in die bonding solder is exempted from restriction by RoHS Annex 7, first item.

Please refer to Annex 8 of this report for the applicable exemptions of RoHS (EU Directive 2002/95/EC)

August 13, 2010 Littelfuse, L.P. Page 5



Annex 1: Analysis Result of Molding Compound (Page 1 of 7)



TEST REPORT

NUMBER: WUXH00002758

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., DATE: AUG 06, 2010

LTD.

EAST 1#, ZHENFA 6 ROAD, SHUO FANG INDUSTRIAL PARK WUXI NATIONAL HIGH-

TECH DEVELOPMENT ZONE, WUXI, JIANGSU, CHINA ATTN: ZHANG XIAOPENG

SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : BLACK COMPOUND.

: MOLDING COMPOUND.

VENDOR : COOKSON ELECTONICS SEMICONDUCTOR PRODUCTS.
COMPONENT OR PART NO. : CK2000C.

: Pb,Cd,Hg,CrVI,PBB PBDE,F,Cl,Br,I. TEST ITEM

TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S) *******************

SUMMARY:

TESTED SAMPLE STANDARD RESULT SUBMITTED SAMPLE WITH REFERENCE TO TEST METHOD OF

IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS OUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT

2005/618/EC

TO BE CONTINUED

PREPARED AND CHECKED BY:

FOR INTERTEK TESTING SERVICES WUXI LTD.

JESSICA LU GENERAL MANAGER

PAGE 1 OF 7

Intertek Testing Services Wuxi Ltd.

No.8 Fubei Road, Xishan Economic Development Zone, Wuxi 214101, Jiangsu, China Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com



Annex 1: Analysis Result of Molding Compound (Page 2 of 7)



TEST REPORT

NUMBER: WUXH00002758

TESTS CONDUCTED

(A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg	g)
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS	ND
(TetraBDE)	
PENTABROMO DIPHENYL ETHERS	ND
(PentaBDE)	
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS	ND
(HeptaBDE) OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NONABDE)	ND ND
, , , , , , , , , , , , , , , , , , , ,	ND ND
DECABROMO DIPHENYL ETHER (DecaBDE)	מא

REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm ND = NOT DETECTED

******************** TO BE CONTINUED

PAGE 2 OF 7

Intertek Testing Services Wuxi Ltd.

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Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com



Annex 1: Analysis Result of Molding Compound (Page 3 of 7)



TEST REPORT

NUMBER: WUXH00002758

TESTS CONDUCTED

(B) RoHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr ⁶⁺)	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV- VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs)& POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED: AUG 02, 2010 TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010 ******************

TO BE CONTINUED

PAGE 3 OF 7

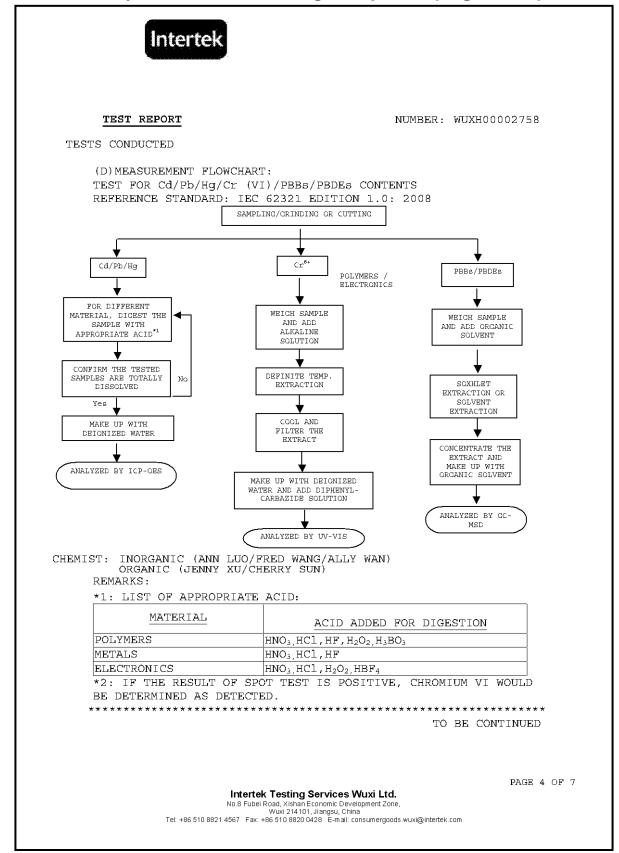
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Annex 1: Analysis Result of Molding Compound (Page 4 of 7)





Annex 1: Analysis Result of Molding Compound (Page 5 of 7)



TEST REPORT

NUMBER: WUXH00002758

TESTS CONDUCTED

([) TEST RESULT SUMMARY :

HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (C1) CONTENT	100
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

(II) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F,Cl, Br,I) CONTENT	WITH REFERENCE TO IEC 61189- 2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS: REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE ******************

TO BE CONTINUED

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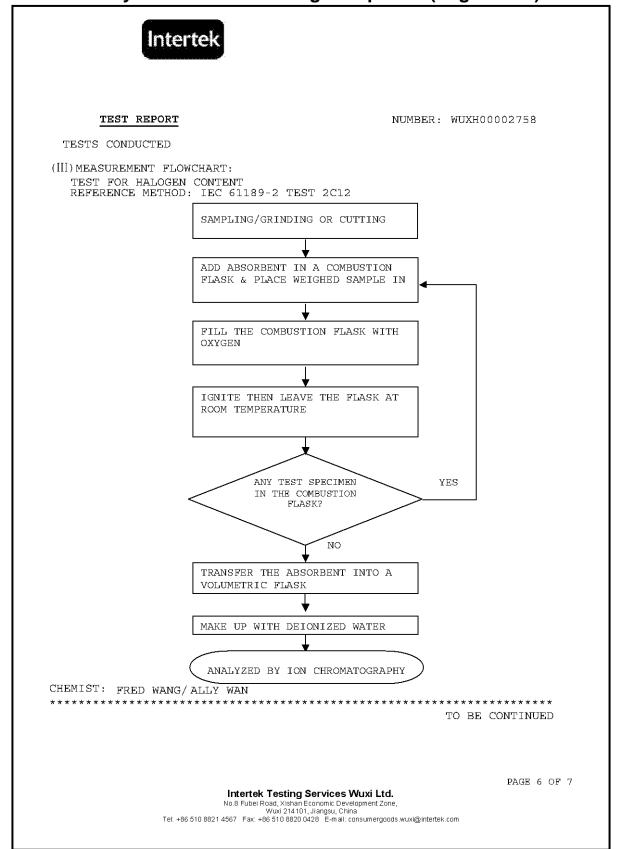
Intertek Testing Services Wuxi Ltd.

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Annex 1: Analysis Result of Molding Compound (Page 6 of 7)





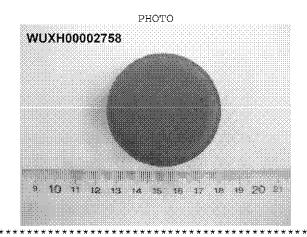
Annex 1: Analysis Result of Molding Compound (Page 7 of 7)



TEST REPORT

TESTS CONDUCTED

NUMBER: WUXH00002758



END OF REPORT

PAGE 7 OF 7

Intertek Testing Services Wuxi Ltd.
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Annex 2: Analysis Result of Lead frame (Page 1 of 4)



Test Report No. SHAML1008240101 Date: 21 Jun 2010 Page 1 of 4

NINGBO ESC PHOTOELECTRON CO., LTD

ECONOMIC & TECHNICAL DEVELOPMENT ZONE, NO.88 YICHENG RD, BEILUN NINGBO, CHINA

The following sample(s) was/were submitted and identified on behalf of the clients as: LEAD FRAME

SGS Job No.: SC100602277 - SH

Material and Mark: KFC

Product Specification: TO LEA FRAME Cu SERIES

Date of Sample Received: 12 Jun 2010

Testing Period: 12 Jun 2010 - 21 Jun 2010

Test Requested: Selected test(s) as requested by client.

Test Method: Please refer to next page(s).

Test Results: Please refer to next page(s).

Signed for and on behalf of SGS-CSTC Ltd.

Fan Jingjie, JJ Approved Signatory

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Annex 2: Analysis Result of Lead frame (Page 2 of 4)



Test Report No. SHAML1008240101 Date: 21 Jun 2010 Page 2 of 4

Test Results:

Test Part Description:

Specimen No. SGS Sample ID Description

1 SHA10-082401.001 Copper metal frame

Remarks:

(1) 1 mg/kg = 1 ppm = 0.0001%

(2) MDL = Method Detection Limit

(3) ND = Not Detected (< MDL)

(4) "-" = Not Regulated

RoHS Directive 2002/95/EC

Test Method: With reference to IEC 62321:2008

- (1) Determination of Cadmium by ICP-OES.
- (2) Determination of Lead by ICP-OES.
- (3) Determination of Mercury by ICP-OES.
- $(4) \, {\sf Determination} \, \, {\sf of} \, \, {\sf Hexavalent} \, \, {\sf Chromium} \, \, {\sf by} \, \, {\sf Spot} \, \, {\sf test} \, {\sf /} \, \, {\sf Colorimetric} \, \, {\sf Method} \, \, {\sf using} \, \, {\sf UV-Vis}.$
- (5) Determination of PBBs / PBDEs by GC-MS.

Test Item(s)	<u>Limit</u>	<u>Unit</u>	<u>MDL</u>	<u>001</u>
Cadmium (Cd)	100	mg/kg	2	ND
Lead (Pb)	1,000	mg/kg	2	11
Mercury (Hg)	1,000	mg/kg	2	ND
Hexavalent Chromium (CrVI)	-	-	\Diamond	Negative
Sum of PBBs	1,000	mg/kg	-	ND
Monobromobiphenyl	-	mg/kg	5	ND
Dibromobiphenyl	-	mg/kg	5	ND
Tribromobiphenyl	-	mg/kg	5	ND
Tetrabromobiphenyl	-	mg/kg	5	ND
Pentabromobiphenyl	-	mg/kg	5	ND
Hexabromobiphenyl	-	mg/kg	5	ND
Heptabromobiphenyl	-	mg/kg	5	ND
Octabromobiphenyl	-	mg/kg	5	ND
Nonabromobiphenyl	-	mg/kg	5	ND
Decabromobiphenyl	-	mg/kg	5	ND
Sum of PBDEs	1,000	mg/kg	-	ND
Monobromodiphenyl ether	-	mg/kg	5	ND

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Annex 2: Analysis Result of Lead frame (Page 3 of 4)



Test Report	No. SHAML100824010	No. SHAML1008240101		Jun 2010	Page 3 of 4
Test Item(s)	<u>Limit</u>	<u>Unit</u>	<u>MDL</u>	<u>001</u>	
Dibromodiphenyl ether	-	mg/kg	5	ND	
Tribromodiphenyl ether	-	mg/kg	5	ND	
Tetrabromodiphenyl ether	-	mg/kg	5	ND	
Pentabromodiphenyl ether	-	mg/kg	5	ND	
Hexabromodiphenyl ether	-	mg/kg	5	ND	
Heptabromodiphenyl ether	=	mg/kg	5	ND	
Octabromodiphenyl ether	-	mg/kg	5	ND	
Nonabromodiphenyl ether	-	mg/kg	5	ND	
Decabromodiphenyl ether	-	mg/kg	5	ND	

Notes:

- (1) The maximum permissible limit is quoted from the document 2005/618/EC amending RoHS directive 2002/95/EC
- (2) Spot-test:

Negative = Absence of CrVI coating, Positive = Presence of CrVI coating;

The tested sample should be further verified by boiling-water-extraction method if the spot test result is Negative or cannot be confirmed.

♦ Boiling-water-extraction:

Negative = Absence of CrVI coating; Positive = Presence of CrVI coating

The detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm² sample surface area.

For corrosion protection coatings on metals: Information on storage conditions and production date of the tested sample is unavailable and thus results of Cr(VI) represent status of the sample at the time of testing.

This document is is said by the Colego by subject to its General Conditions of Service princip devices a vertice or request or accessive at his Hower spacetimes, and unindiffices, then and for reference for a subject to the condition of the subject to the subje



Annex 2: Analysis Result of Lead frame (Page 4 of 4)

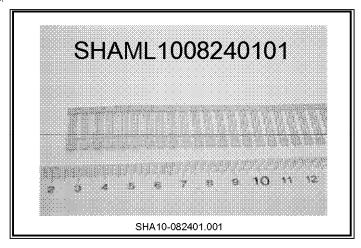
Test Report

No. SHAML1008240101

Date: 21 Jun 2010

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Sample photo:



SGS authenticate the photo on original report only

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Annex 3: Analysis Result of Lead finish (page 1 of 6)



Test Report No.: GZ0912123513/CHEM Date: JAN 06, 2010 Page 1 of 6

GAOXIN STANNUM INDUSTRY (HUIZHOU) CO., LTD.
XIANAN INDUSTRIAL CENTRE, YUANZHOU TOWN, BOLUO, COUNTY, HUIZHOU CITY, CHINA

The following sample(s) was/were submitted and identified on behalf of the applicant as Solder Ball 99.98

SGS Job No. : SZ12327648

SGS Internal Reference No. : 47.24

Date of Sample Received : DEC 30, 2009

Testing Period : DEC 30, 2009 TO JAN 06, 2010

Test Requested : Selected test (s) as requested by client.

Test Method : Please refer to next page(s).

Test Result(s) : Please refer to next page(s).

Signed for and on behalf of SGS-CSTC Ltd.

Manson Yang Sr. Engineer

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Annex 3: Analysis Result of Lead finish (page 2 of 6)



Test Report No.: GZ0912123513/CHEM Date: JAN 06, 2010 Page 2 of 6

Test Results:

Description for specimen 1 : Silvery metal

Elementary Analysis

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Cadmium (Cd) Lead (Pb) Mercury (Hg) Hexavalent Chromium (CrVI) by	mg/kg mg/kg mg/kg -	IEC 62321: 2008, ICP-OES IEC 62321: 2008, ICP-OES IEC 62321: 2008, ICP-OES	N.D. 24 N.D.	2 2 2
boiling water extraction		IEC 62321: 2008, UV-Vis	Negative	\Diamond

- 1. mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
 3. MDL = Method Detection Limit
- 4. ♦ = Spot test:

Negative = Absence of CrVI coating, Positive = Presence of CrVI coating;

(The tested sample should be further verified by boiling water extraction method if the spot test result is negative or cannot be confirmed.)

Boiling water extraction:

Negative = Absence of CrVI coating

Positive = Presence of CrVI coating; the detected concentration in boiling water extraction solution is equal or greater than 0.02 mg/kg with 50 cm² sample surface area.

Storage conditions and production date of the tested sample are unavailable and thus results of Cr(VI) represent status of the sample at the time of testing.

5. "-" = Not regulated

Flame Retardants

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Sum of PBBs	mg/kg	-	N.D.	_
Monobromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Dibromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Tribromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Tetrabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Pentabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Hexabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Heptabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Octabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Nonabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Decabromobiphenyl	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Sum of PBDEs	mg/kg	=	N.D.	-
Monobromodiphenyl ether	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Dibromodiphenyl ether	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Tribromodiphenyl ether	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5
Tetrabromodiphenyl ether	mg/kg	IEC 62321: 2008, GC-MS	N.D.	5

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| Taraca Racianten Parlanguagan Surveya Talming Designer Bain Companision (50050) | 1 (F6-2) (201855) | 1 (F6-4) (1078125) MINO: 550562 1 60-25(42)5565 1 96-20(10)75(25 * 148-40/10)89(40) 中国一广创一统的技术开及区科学规划基础190号



Annex 3: Analysis Result of Lead finish (page 3 of 6)



No.: GZ09	12123513/CHEM	Date: JAN 06, 2010	Page :	3 of 6
mg/kg			N.D.	5
mg/kg		,	N.D.	5
mg/kg	IEC 62321: 2008	, GC-MS	N.D.	5
mg/kg	IEC 62321: 2008	, GC-MS	N.D.	5
mg/kg	IEC 62321: 2008	, GC-MS	N.D.	5
mg/kg	IEC 62321: 2008	, GC-MS	N.D.	5
	mg/kg mg/kg mg/kg mg/kg mg/kg	mg/kg IEC 62321: 2008	mg/kg IEC 62321: 2008, GC-MS	mg/kg IEC 62321: 2008, GC-MS N.D. mg/kg IEC 62321: 2008, GC-MS N.D.

Note:

- 1. mg/kg = ppm 2. N.D. = Not Detected (< MDL) 3. MDL = Method Detection Limit 4. "-" = Not regulated

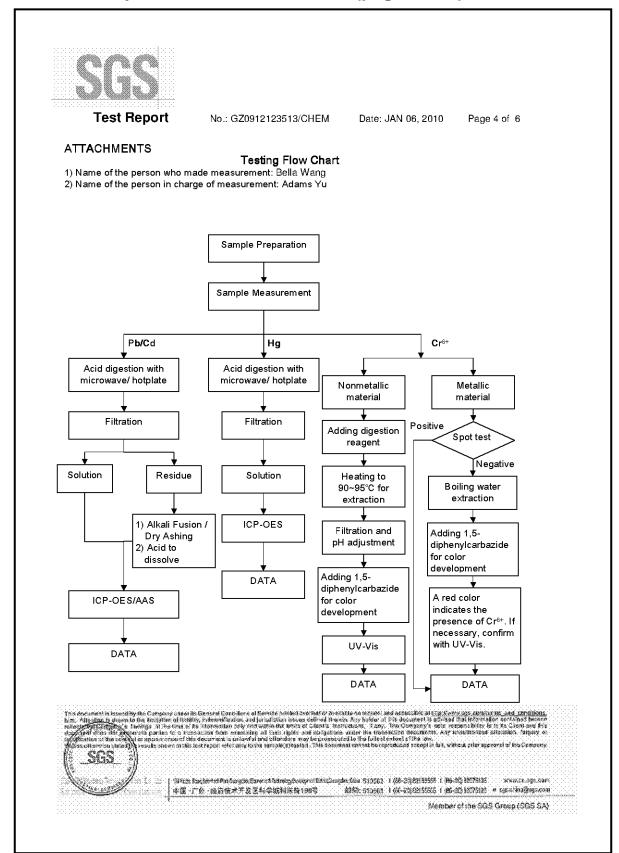
Remark: Results & photo(s) of this report refer to test report GZ0912123511/CHEM.

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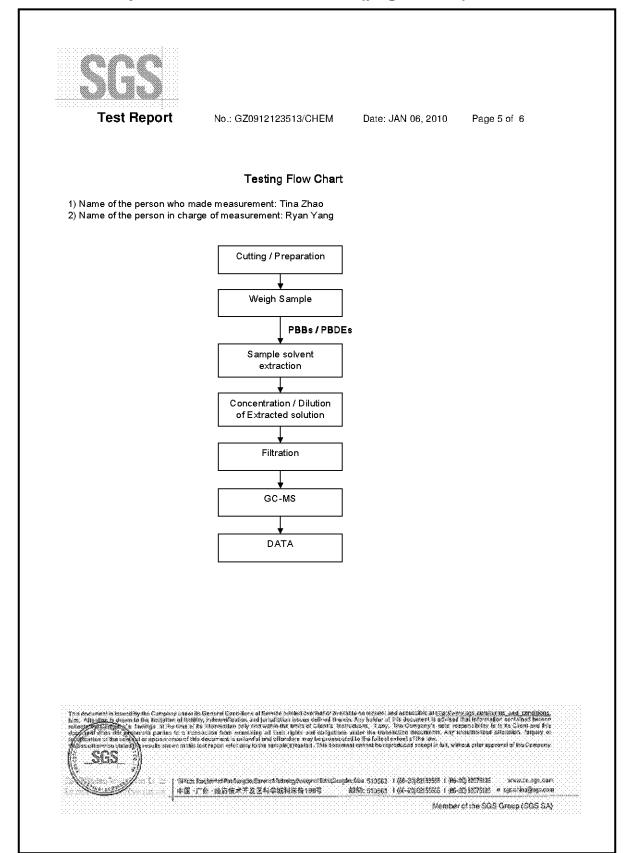


Annex 3: Analysis Result of Lead finish (page 4 of 6)



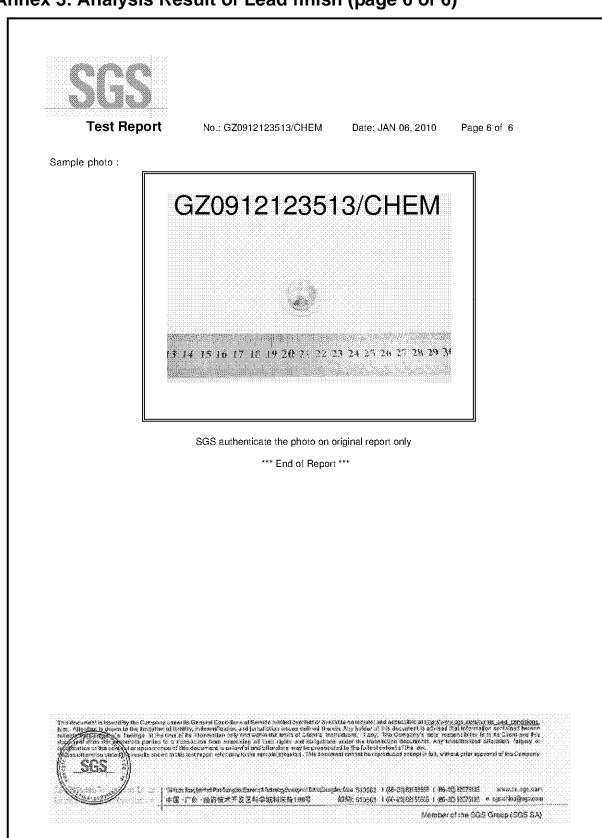


Annex 3: Analysis Result of Lead finish (page 5 of 6)





Annex 3: Analysis Result of Lead finish (page 6 of 6)





Annex 4: Analysis Result of Ni-plated Wafer (Page 1 of 7)



TEST REPORT

NUMBER: WUXH00002719

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO.,

DATE: AUG 06, 2010

LTD.

EAST 1#,ZHENFA 6 ROAD, SHUO FANG INDUSTRIAL PARK WUXI NATIONAL HIGH-

TECH DEVELOPMENT ZONE, WUXI,JIANGSU,CHINA ATTN: ZHANG XIAOPENG

SAMPLE DESCRIPTION:

ONE(1)PIECE OF SUBMITTED SAMPLE SAID TO BE :SILVER GREY METAL.

ITEM NAME : SILICON WAFER WITH NICKEL PLATING.

VENDOR : CONCORD.

COMPONENT OR PART NO. : SILICON+NICKEL.

TEST ITEM : Pb,Cd,Hg,CrVI,PBB PBDE,F,Cl,Br,I.

TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

SUMMARY:

TESTED SAMPLE STANDARD

RESULT

SUBMITTED SAMPLE WITH REFERENCE TO TEST METHOD OF

IEC 62321 EDITION 1.0: 2008 AND MAXIMUM CONCENTRATION LIMITS QUOTED FROM ROHS DIRECTIVES 2002/95/EC AND AMENDMENT

2005/618/EC

TO BE CONTINUED

PREPARED AND CHECKED BY:

FOR INTERTEK TESTING SERVICES WUXI LTD.

JESSICA LU GENERAL MANAGER

PAGE 1 OF 7

Intertek Testing Services Wuxi Ltd.

No.8 Fubel Road, Xishan Economic Development Zone,
Wuxi 214101, Jiangsu, China
Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mall: consumergoods.wuxi@intertek.com



Annex 4: Analysis Result of Ni-plated Wafer (Page 2 of 7)



TEST REPORT

NUMBER: WUXH00002719

TESTS CONDUCTED

(A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI)(Cr ⁶⁺) RESULT (BY BOILING WATER EXTRACTION ON METAL) (mg/kg WITH 50cm ²)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg	g)
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS (TetraBDE)	ND
PENTABROMO DIPHENYL ETHERS (PentaBDE)	ND
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (Heptabde)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

REMARK:

 $\mbox{mg}/\mbox{kg} = \mbox{MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm ND = NOT DETECTED$

mg/kg WITH $50cm^2 = MILLIGRAM$ PER KILOGRAM WITH 50 SQUARE CENTIMETER

TO BE CONTINUED

PAGE 2 OF 7

Intertek Testing Services Wuxi Ltd.

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Annex 4: Analysis Result of Ni-plated Wafer (Page 3 of 7)



TEST REPORT

NUMBER: WUXH00002719

TESTS CONDUCTED

(B) ROHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr ⁶⁺)	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (FOR METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY BOILING WATER EXTRACTION AND DETERMINED BY UV-VIS SPECTROPHOTOMETER	0.02mg/kg WITH 50cm ² (IN TESTING SOLUTION)
POLYBROMINATED BIPHENYLS (PBBs)& POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

TO BE CONTINUED

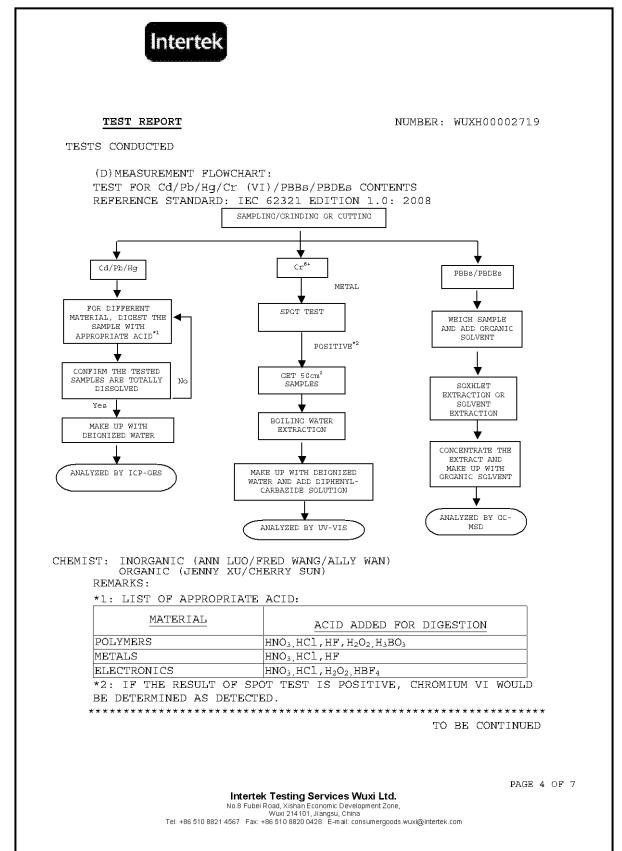
PAGE 3 OF 7

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Annex 4: Analysis Result of Ni-plated Wafer (Page 4 of 7)





Annex 4: Analysis Result of Ni-plated Wafer (Page 5 of 7)



TEST REPORT

NUMBER: WUXH00002719

TESTS CONDUCTED

(I) TEST RESULT SUMMARY :

HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (C1) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

(II) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F,Cl, Br,I) CONTENT	WITH REFERENCE TO IEC 61189- 2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

TO BE CONTINUED

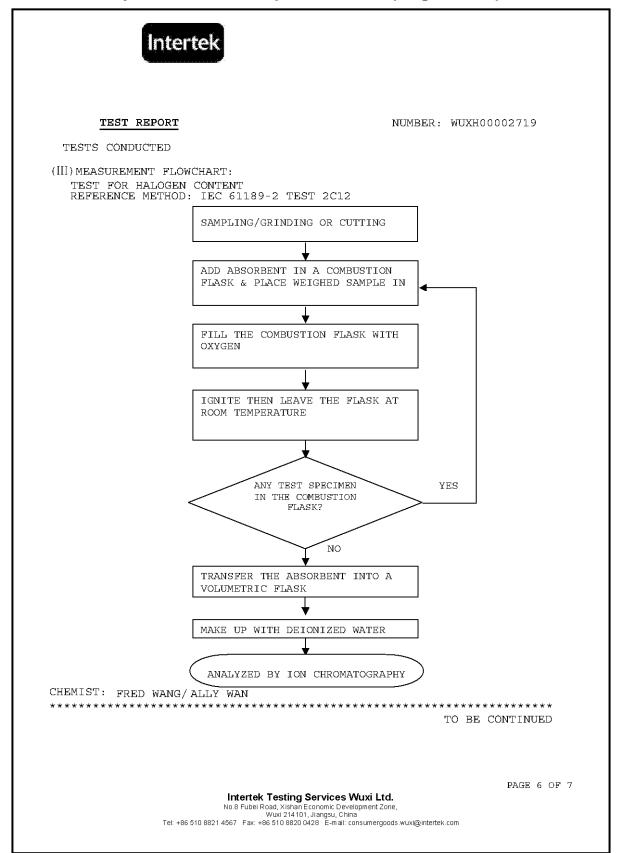
PAGE 5 OF 7

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Annex 4: Analysis Result of Ni-plated Wafer (Page 6 of 7)





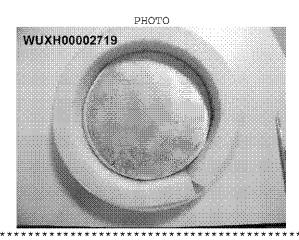
Annex 4: Analysis Result of Ni-plated Wafer (Page 7 of 7)



TEST REPORT

TESTS CONDUCTED

NUMBER: WUXH00002719



END OF REPORT

PAGE 7 OF 7

Intertek Testing Services Wuxi Ltd.

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Annex 5: Analysis Result of Passivation Glass (Page 1 of 7)



TEST REPORT

NUMBER: WUXH00002721

APPLICANT: CONCORD SEMICONDUCTOR (WUXI) CO.,

DATE: AUG 06, 2010

LTD.

EAST 1#,ZHENFA 6 ROAD, SHUO FANG INDUSTRIAL PARK WUXI NATIONAL HIGH-

TECH DEVELOPMENT ZONE, WUXI,JIANGSU,CHINA ATTN: ZHANG XIAOPENG

SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : WHITE POWDER.

ITEM NAME : WAFER PASSIVATION.

VENDOR : PROPRIETY.
COMPONENT OR PART NO. : PROPRIETY.

TEST ITEM : Pb,Cd,Hg,CrVI,PBB PBDE,F,Cl,Br,I.

TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

TO BE CONTINUED

PREPARED AND CHECKED BY:

FOR INTERTEK TESTING SERVICES WUXI LTD.

JESSICA LU GENERAL MANAGER

PAGE 1 OF 7

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Annex 5: Analysis Result of Passivation Glass (Page 2 of 7)



TEST REPORT

NUMBER: WUXH00002721

TESTS CONDUCTED

(A) TEST RESULT SUMMARY:

TESTING ITEM	RESULT
CADMIUM (Cd) CONTENT (mg/kg)	ND
LEAD (Pb) CONTENT (mg/kg)	207400
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg	g)
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs) (mg/kg)
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS	ND
(TetraBDE)	
PENTABROMO DIPHENYL ETHERS	ND
(PentaBDE)	
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctabDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND
L	1

REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm ND = NOT DETECTED

= THE RESULT IS FOR REFERENCE ONLY

TO BE CONTINUED

PAGE 2 OF 7

Intertek Testing Services Wuxi Ltd.

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Annex 5: Analysis Result of Passivation Glass (Page 3 of 7)



TEST REPORT

NUMBER: WUXH00002721

TESTS CONDUCTED

(B) ROHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr ⁶⁺)	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV- VIS SPECTROPHOTOMETER	1 mg/kg
POLYBROMINATED BIPHENYLS (PBBs)& POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

DATE SAMPLE RECEIVED:AUG 02, 2010
TESTING PERIOD:AUG 02, 2010 TO AUG 05, 2010

TO BE CONTINUED

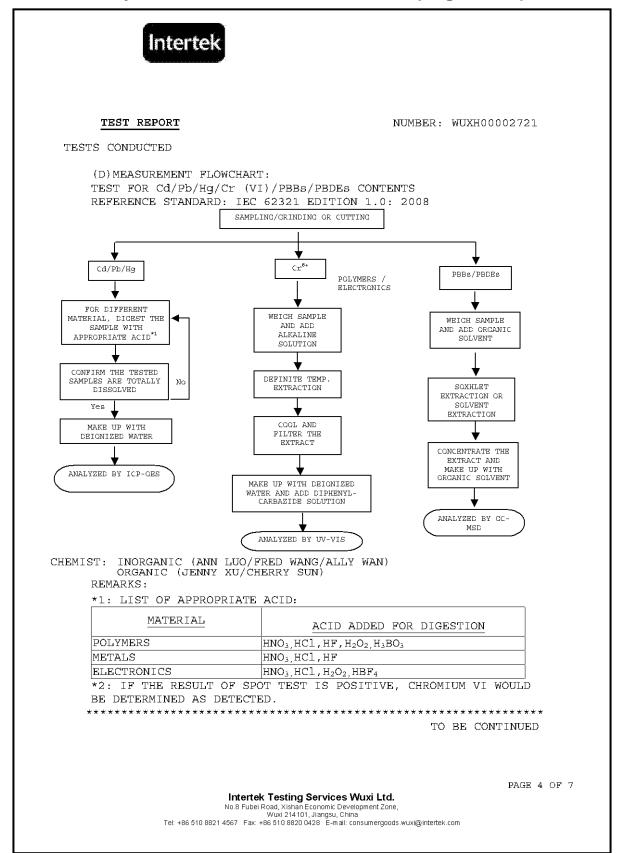
PAGE 3 OF 7

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Annex 5: Analysis Result of Passivation Glass (Page 4 of 7)





Annex 5: Analysis Result of Passivation Glass (Page 5 of 7)



TEST REPORT

NUMBER: WUXH00002721

TESTS CONDUCTED

(I) TEST RESULT SUMMARY :

HALOGEN CONTENT :

TESTING ITEM	RESULT (ppm)
FLUORINE (F) CONTENT	ND
CHLORINE (C1) CONTENT	ND
BROMINE (Br) CONTENT	ND
IODINE (I) CONTENT	ND

REMARKS : ppm = PARTS PER MILLION = mg/kg

ND = NOT DETECTED

DATE SAMPLE RECEIVE: AUG 02, 2010

TEST PERIOD: AUG 02, 2010 TO AUG 05, 2010

(II) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
HALOGEN (F,Cl, Br,I) CONTENT	WITH REFERENCE TO IEC 61189- 2:2006 BY COMBUSTION FLASK AND DETERMINED BY ION CHROMATOGRAPHY	50 ppm

REMARKS: REPORTING LIMIT = QUANTITATION LIMIT OF ANALYTE IN SAMPLE

TO BE CONTINUED

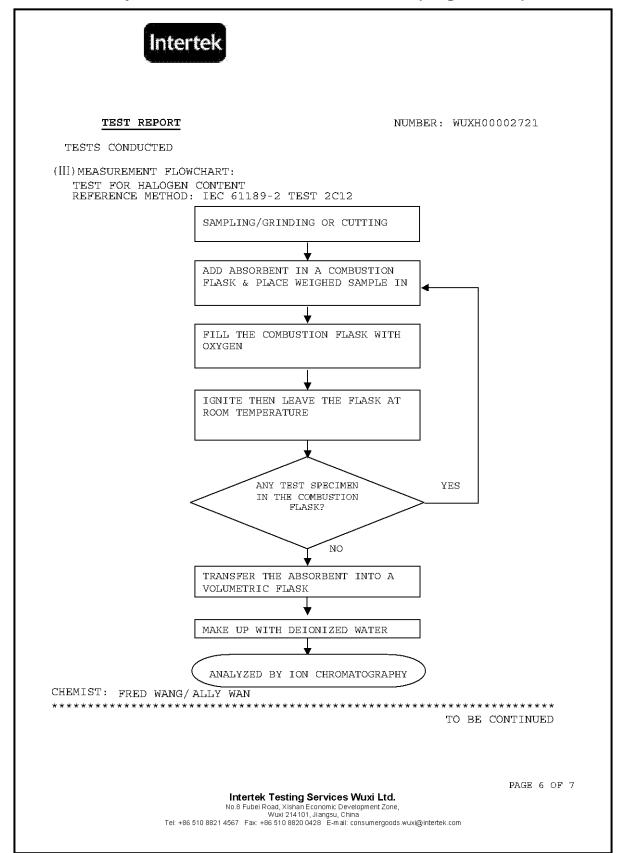
PAGE 5 OF 7

Intertek Testing Services Wuxi Ltd.

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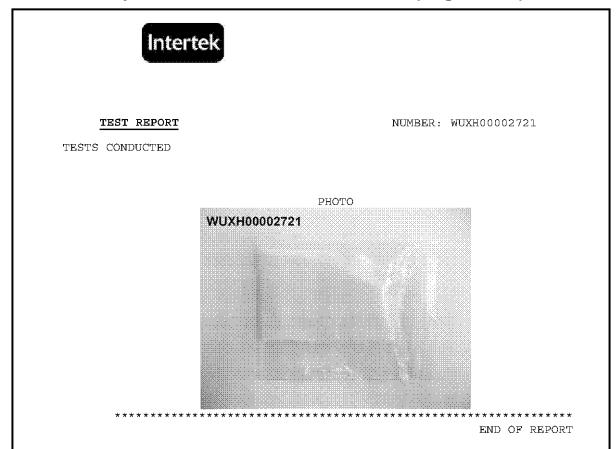


Annex 5: Analysis Result of Passivation Glass (Page 6 of 7)





Annex 5: Analysis Result of Passivation Glass (Page 7 of 7)



PAGE 7 OF 7

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Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mail: consumergoods.wuxi@intertek.com



Annex 6: Analysis Result of Die Bonding Solder (Page 1 of 7)



Test ReportNo. CANEC1001775101 Date: 29 Apr 2010 Page 1 of 7

SHENZHEN EARLYSUN TECHNOLOGY CO.,LTD 6F,BUILDING OF BAODAZHOU,INTERCHANGE OF LONGZHU AVENUE AND LONGZHU 3 ROAD,TAOYUAN STEET,NANSHAN,SHENZHEN,CHINA

The following sample(s) was/were submitted and identified on behalf of the clients as :

High-temperature Solder Paste

SGS Job No. : 12486589 - SZ

Client Ref. Information : ES-500、ES-660 (Sn5Pb92.5Ag2.5 Sn5Pb95 Sn10Pb90 Sn20Pb88Ag2

Sn20Pb78Ag2 Sn3Pb97 Sn5Pb93Ag2) MIXTURE

Date of Sample Received : 31 Mar 2010

Testing Period : 31 Mar 2010 - 06 Apr 2010

Test Requested : Selected test(s) as requested by client.

Test Method : Please refer to next page(s).

Test Results : Please refer to next page(s).

Conclusion : A:Based on the performed tests on submitted sample(s), the results comply

with the RoHS Directive 2002/95/EC and its subsequent amendments.

Signed for and on behalf of SGS-CSTC Ltd.

Manson Yang Sr. Engineer

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Member of the SGS Gross (SGS SA)



Annex 6: Analysis Result of Die Bonding Solder (Page 2 of 7)



Test ReportNo. CANEC1001775101 Date: 29 Apr 2010 Page 2 of 7

Test Results:

ID for specimen 1 : CAN10-017751.001
Description for specimen 1 : Grey paste

A:RoHS Directive 2002/95/EC

Test Item(s)	Unit	Test Method (Reference)	Result	MDL	Limit
Cadmium (Cd)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2	100
Lead (Pb)	mg/kg	IEC 62321:2008, ICP-OES	891100<1>	2	1000
Mercury (Hg)	mg/kg	IEC 62321:2008, ICP-OES	N.D.	2	1000
Hexavalent Chromium (CrVI) by	mg/kg	IEC 62321:2008, UV-Vis	N.D.	2	1000
alkaline extraction					
Sum of PBBs	mg/kg	-	N.D.	-	1000
Monobromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Dibromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tribromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tetrabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Pentabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Hexabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Heptabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Octabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Nonabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Decabromobiphenyl	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Sum of PBDEs	mg/kg	-	N.D.	-	1000
Monobromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Dibromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tribromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Tetrabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Pentabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Hexabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Heptabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Octabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Nonabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	
Decabromodiphenyl ether	mg/kg	IEC 62321:2008, GC-MS	N.D.	5	

Note:

- 1. mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
- 3. MDL = Method Detection Limit
- 4. "-" = Not regulated
- 5. The results of Pb shown are only for reference
- 6.The result(s) shown is/are of the total weight of dried sample.

7.Remark<1>: According to the declaration from client, the source of Lead in specimen could be from the high melting temperature type solder, while Lead in high melting temperature type solders is exempted by RoHS

This deciment is exact by the Contemp single-thank is which is inhibitors of Berthe pictors white it is now by the provided on the provided of the Contemp single of the Contemp and Conditions in Experiment Technology of the Contemp and Conditions and Contemp and Con

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Membero she SGS Group (SGS SA)



Annex 6: Analysis Result of Die Bonding Solder (Page 3 of 7)



Test Report

No. CANEC1001775101

Date: 29 Apr 2010

Page 3 of 7

regulatory (Directive 2002/95/EC of the European Parliament and of the council of 27 January 2003).

B:Halogen

Test Item(s)	Unit	Test Method (Reference)	Result	MDL
Fluorine (F)	mg/kg	BS EN 14582:2007, IC	N.D.	50
Chlorine (CI)	mg/kg	BS EN 14582:2007, IC	N.D.	50
Bromine (Br)	mg/kg	BS EN 14582:2007, IC	240	50
lodine (l)	mg/kg	BS EN 14582:2007, IC	N.D.	50

Note:

- 1. mg/kg = ppm
- 2. N.D. = Not Detected (< MDL)
- 3. MDL = Method Detection Limit
- 4. The result(s) shown is/are of the total weight of wet sample.

Remark1: For Halogen tests, specimen is/are extracted by organic solvent and subsequently burned in oxygen bomb

Remark2: Results and photo(s) of this report refer to test report CANEC1001467301.

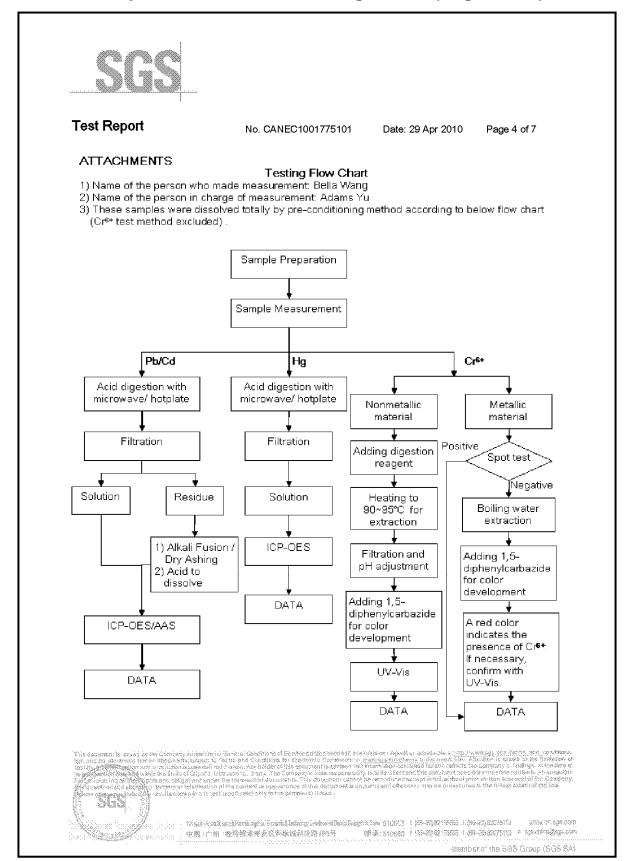
Remark3: Results and photo(s) of test report CANEC1001467301 refer to test report CANEC1001261801.

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Member of the SGS Group (SGS SA)

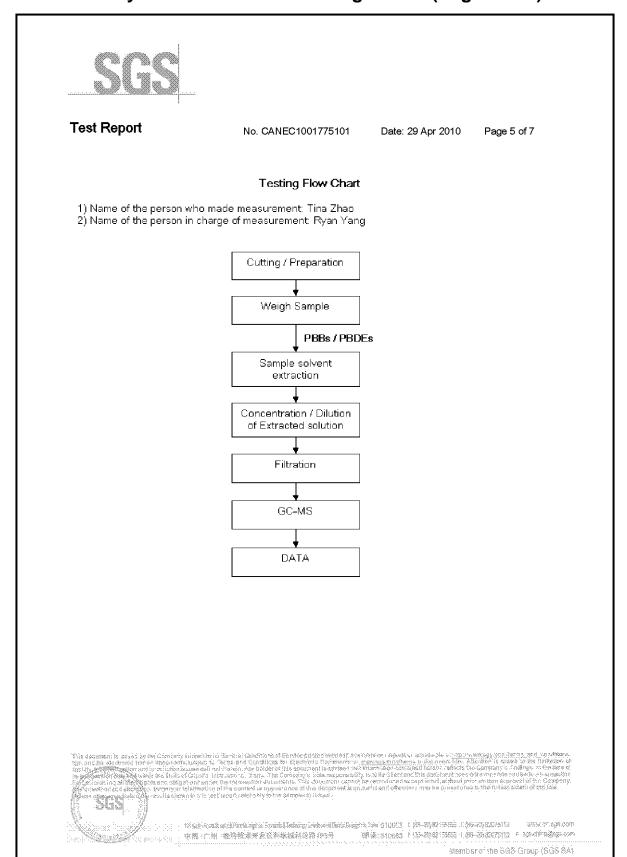


Annex 6: Analysis Result of Die Bonding Solder (Page 4 of 7)



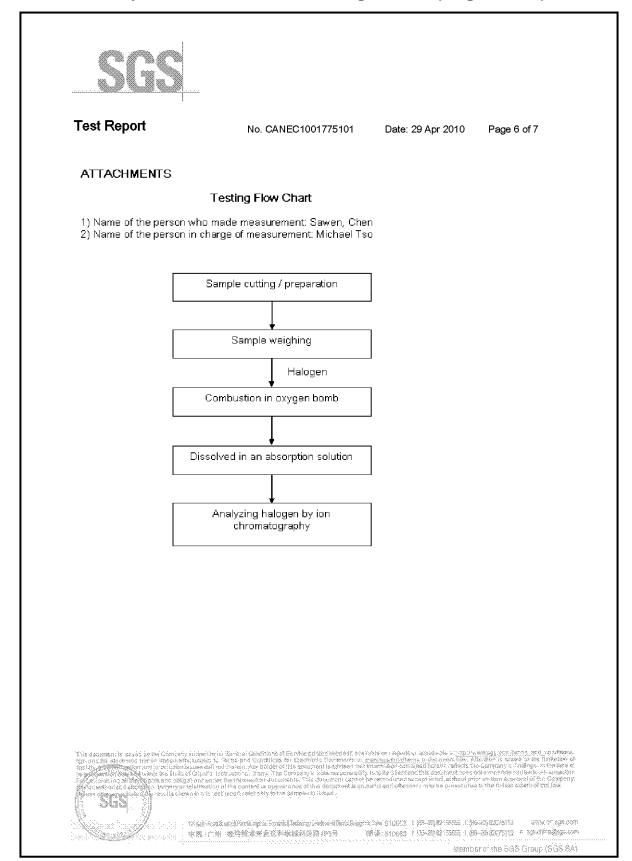


Annex 6: Analysis Result of Die Bonding Solder (Page 5 of 7)





Annex 6: Analysis Result of Die Bonding Solder (Page 6 of 7)





Annex 6: Analysis Result of Die Bonding Solder (Page 7 of 7)



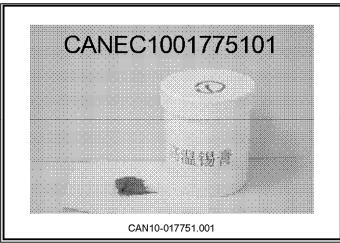
Test Report

No. CANEC1001775101

Date: 29 Apr 2010

Page 7 of 7

Sample photo:



SGS authenticate the photo on original report only

*** End of Report ***

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Annex 7: Analysis Result of Ceramic Substrate (Page 1 of 5)



TEST REPORT

NUMBER: WUXH00002764

APPLICANT: CONCORD SEMICONDUCTOR(WUXI) CO., LTD. DATE: AUG 06, 2010

EAST 1#,ZHENFA 6 ROAD, SHUO FANG INDUSTRIAL PARK WUXI NATIONAL HIGH-

TECH DEVELOPMENT ZONE, WUXI,JIANGSU,CHINA ATTN: ZHANG XIAOPENG

SAMPLE DESCRIPTION:

ONE (1) PIECE OF SUBMITTED SAMPLE SAID TO BE : GREY CERAMIC.

ITEM NAME : CERAMIC.
VENDOR : CERAMTEC AG.
COMPONENT OR PART NO. : CERAMIC.

TEST ITEM : Pb,Cd,Hg,CrVI,PBB PBDE.

TEST MODE : AS PER CLIENT'S REQUEST, THE TESTED SAMPLE

WAS TESTED AS A WHOLE AND SAMPLED.

TESTS CONDUCTED:

AS REQUESTED BY THE APPLICANT, FOR DETAILS REFER TO ATTACHED PAGE(S)

TO BE CONTINUED

PREPARED AND CHECKED BY:

FOR INTERTEK TESTING SERVICES WUXI LTD.

JESSICA LU GENERAL MANAGER

PAGE 1 OF 5

Intertek Testing Services Wuxi Ltd.

No.8 Fubel Road, Xishan Economic Development Zone,
Wuxi 214101, Jiangsu, China
Tel: +86 510 8821 4567 Fax: +86 510 8820 0428 E-mall: consumergoods.wuxi@intertek.com



Annex 7: Analysis Result of Ceramic Substrate (Page 2 of 5)



TEST REPORT

NUMBER: WUXH00002764

TESTS CONDUCTED

(A) TEST RESULT SUMMARY:

CADMIUM (Cd) CONTENT (mg/kg)	ND
	147
LEAD (Pb) CONTENT (mg/kg)	ND
MERCURY (Hg) CONTENT (mg/kg)	ND
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (mg/kg) (FOR NON-METAL)	ND
POLYBROMINATED BIPHENYLS (PBBs) (mg/kg)	
MONOBROMO BIPHENYLS (MonoBB)	ND
DIBROMO BIPHENYLS (DiBB)	ND
TRIBROMO BIPHENYLS (TriBB)	ND
TETRABROMO BIPHENYLS (TetraBB)	ND
PENTABROMO BIPHENYLS (PentaBB)	ND
HEXABROMO BIPHENYLS (HexaBB)	ND
HEPTABROMO BIPHENYLS (HeptaBB)	ND
OCTABROMO BIPHENYLS (OctaBB)	ND
NONABROMO BIPHENYLS (NonaBB)	ND
DECABROMO BIPHENYL (DecaBB)	ND
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	(mg/kg)
MONOBROMO DIPHENYL ETHERS (MonoBDE)	ND
DIBROMO DIPHENYL ETHERS (DiBDE)	ND
TRIBROMO DIPHENYL ETHERS (TriBDE)	ND
TETRABROMO DIPHENYL ETHERS	ND
(TetraBDE)	
PENTABROMO DIPHENYL ETHERS	ND
(PentaBDE)	
HEXABROMO DIPHENYL ETHERS (HexaBDE)	ND
HEPTABROMO DIPHENYL ETHERS (HeptaBDE)	ND
OCTABROMO DIPHENYL ETHERS (OctaBDE)	ND
NONABROMO DIPHENYL ETHERS (NonaBDE)	ND
DECABROMO DIPHENYL ETHER (DecaBDE)	ND

REMARK:

mg/kg = MILLIGRAM PER KILOGRAM BASED ON DRY WEIGHT= ppm ND = NOT DETECTED

TO BE CONTINUED

PAGE 2 OF 5

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August 13, 2010 Littelfuse, L.P. Annex 7-2



Annex 7: Analysis Result of Ceramic Substrate (Page 3 of 5)



TEST REPORT

NUMBER: WUXH00002764

TESTS CONDUCTED

(B) ROHS REQUIREMENT:

RESTRICTED SUBSTANCES	LIMITS
CADMIUM (Cd)	0.01% (100 mg/kg)
LEAD (Pb)	0.1% (1000 mg/kg)
MERCURY (Hg)	0.1% (1000 mg/kg)
CHROMIUM (VI) (Cr ⁶⁺)	0.1% (1000 mg/kg)
POLYBROMINATED BIPHENYLS (PBBs)	0.1% (1000 mg/kg)
POLYBROMINATED DIPHENYL ETHERS (PBDEs)	0.1% (1000 mg/kg)

THE ABOVE LIMITS WERE QUOTED FROM 2002/95/EC AND AMENDMENT 2005/618/EC FOR HOMOGENEOUS MATERIAL.

(c) TEST METHOD:

TESTING ITEM	TESTING METHOD	REPORTING LIMIT
CADMIUM (Cd) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
LEAD (Pb) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
MERCURY (Hg) CONTENT	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ACID DIGESTION AND DETERMINED BY ICP- OES	2 mg/kg
CHROMIUM (VI) (Cr ⁶⁺) CONTENT (FOR NON-METAL)	WITH REFERENCE TO IEC 62321 EDITION 1.0: 2008, BY ALKALINE DIGESTION AND DETERMINED BY UV- VIS SPECTROPHOTOMETER	l mg/kg
POLYBROMINATED BIPHENYLS (PBBs)& POLYBROMINATED DIPHENYL ETHERS (PBDEs)	WITH REFERENCE TO IEC IEC 62321 EDITION 1.0: 2008, BY SOLVENT EXTRACTION AND DETERMINED BY GC/MS AND FURTHER HPLC CONFIRMATION WHEN NECESSARY.	5 mg/kg

TO BE CONTINUED

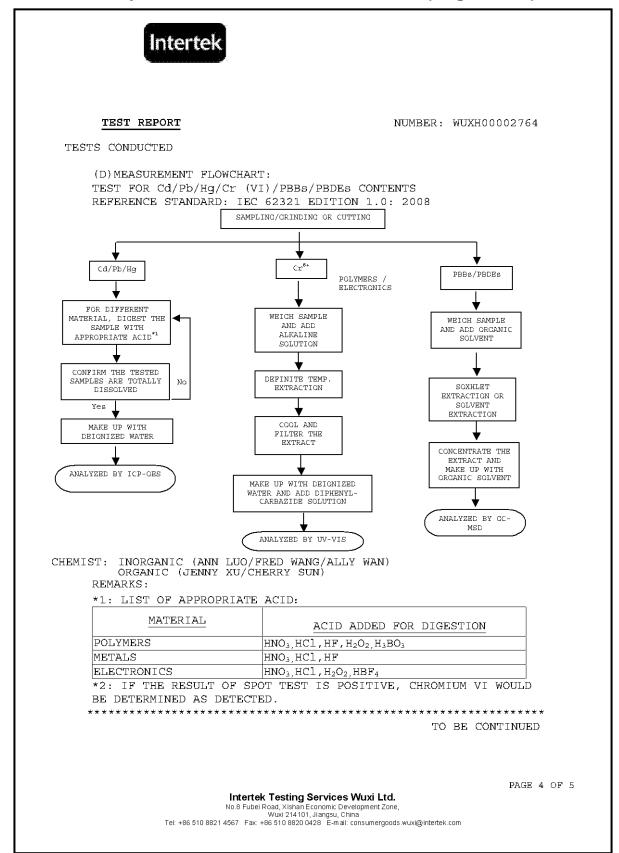
PAGE 3 OF 5

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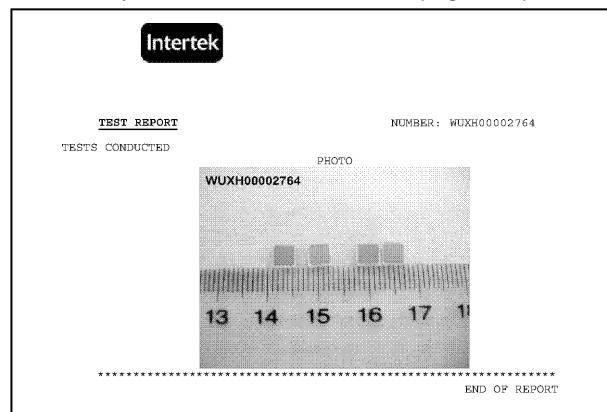
Annex 7: Analysis Result of Ceramic Substrate (Page 4 of 5)



August 13, 2010 Littelfuse, L.P. Annex 7-4



Annex 7: Analysis Result of Ceramic Substrate (Page 5 of 5)



PAGE 5 OF 5

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Annex 8: Applicable RoHS exemptions

	13.2,2003 EN	Official Journal of th	ic European Union	L 37/19
	DIRECTIVE 20	02/95/EC OF THE EUROPEA of 27 Janu	AN PARLIAMENT AND OF THE COUNCIL usry 2003	
_	on the restriction of t	he use of certain hazardous	substances in electrical and electronic equipm	ent
1	3.2.2003 EN	Official Journal of	to be protected and an overall strategy restricts the use of cadmium and stimula	
	Article 4		substitutes should therefore be implem	
	Prevention			
co b (F th w ao	. Member States shall ensure that, from ectrical and electronic equipment pur on ontain lead, mercury, cadmium, hexavale rominated hiphenyls (PBB) or polybromic BDE). National measures restricting or p ness substances in electrical and electron rere adopted in line with Community la doption of this Directive may be main 1006.	the market does not out chromium, poly- nated diphenyl ethers rohibiting the use of it equipment which egislation before the		
13.2.2		applications listed in	European Union	L 37/23
tl	е Аппех.			
		ANNEX	<i>(</i>	
	Applications of lead, mercury, ca	of Article		virements
	• •	a lamps not exceeding 5 mg		
	Moreany in carrieds (Increscent	James for general reprocess	•	
	Mercury in straight fluorescent halophosphate	lamps for general purposes i	not exceeding:	
	— halophosphate	, , , , , , ,	not exceeding: 10 mg	
	, ,	ifetime	not exceeding:	
	 halophosphate triphosphate with normal l 	ifetime time	not exceeding: 10 mg 5 mg	
	 halophosphate triphosphate with normal l triphosphate with long life 	ifetime time lamps for special purposes.	not exceeding: 10 mg 5 mg 8 mg.	
	 halophosphate triphosphate with normal l uriphosphate with long life Mercury in straight fluorescent 	ifetime time lamps for special purposes. ecifically mentioned in this A	not exceeding: 10 mg 5 mg 8 mg.	
	halophosphate triphosphate with normal life triphosphate with long life 3. Mercury in straight fluorescent 4. Mercury in other lamps not sp 5. Lead in glass of cathode ray to	ifetime time lamps for special purposes. ecifically mentioned in this A bes, electronic components a steel containing up to 0,35 9	not exceeding: 10 mg 5 mg 8 mg. Annex. Ind fluorescent tubes. % lead by weight, aluminium containing up to	0,4 % leaď
	 halophosphate triphosphate with normal learning triphosphate with long life Mercury in straight fluorescent Mercury in other lamps not sp Lead in glass of cathode ray to Lead as an alloying element in by weight and as a copper allo 	ifetime lamps for special purposes. ecifically mentioned in this A bes, electronic components a steel containing up to 0,35 9 by containing up to 4 % lead by	not exceeding: 10 mg 5 mg 8 mg. Annex. Ind fluorescent tubes. % lead by weight, aluminium containing up to	_
	 halophosphate triphosphate with normal least triphosphate with long life Mercury in straight fluorescent Mercury in other lamps not sp Lead in glass of cathode ray tu Lead as an alloying element in by weight and as a copper alle Lead in high melting temp 	ifetime lamps for special purposes. ecifically mentioned in this A bes, electronic components a steel containing up to 0,35 9 sy containing up to 4 % lead b erature type solders (i.e. tin-le	not exceeding: 10 mg 5 mg 8 mg. Annex. Ind fluorescent tubes. % lead by weight, aluminium containing up to by weight.	_
	 halophosphate triphosphate with normal learning triphosphate with long life Mercury in straight fluorescent Mercury in other lamps not sp Lead in glass of cathode ray tu Lead as an alloying element in by weight and as a copper alle Lead in high melting tempered in solders for servers, 	ifetime lamps for special purposes. ecifically mentioned in this A bes, electronic components a steel containing up to 0,35 9 sy containing up to 4 % lead b erature type solders (i.e. tin-le storage and storage array syst k infrastructure equipment fo	not exceeding: 10 mg 5 mg 8 mg. Annex. and fluorescent tubes. % lead by weight, aluminium containing up to by weight. and solder alloys containing more than 85 % lead solder alloys containing more than 85 % lead.	ad),
	 halophosphate triphosphate with normal learning in triphosphate with long life Mercury in straight fluorescent Mercury in other lamps not sp Lead in glass of cathode ray to Lead as an alloying element in by weight and as a copper alle Lead in high melting temperated in solders for servers, lead in solders for networl 	ifetime lamps for special purposes. ecifically mentioned in this A bes, electronic components a steel containing up to 0,35 9 by containing up to 4 % lead b erature type solders (i.e. tin-le storage and storage array syst k infrastructure equipment for unication,	10 mg 5 mg 8 mg. Annex. Ind fluorescent tubes. It lead by weight, aluminium containing up to by weight, aluminium containing up to by weight. It was solder alloys containing more than 85 % leaterns (exemption granted until 2010), or switching, signalling, transmission as well a	ad),